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APPLICATION

LIST OF ART CITED BY APPLICANT
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ATTY. DOCKET NO.
IK-0134APPLICANT(S)
Seung Jin OH; Ik Kyu LEE; Chan Kyoo
JANG and Ki Cheol WOOFILING DATE
May 10, 2006

GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
	6,483,695 B1	11/19/2002	Hartstein	361	680	6/24/1996

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	JP 2000-274923	10/6/2000	JAPAN (Full Japanese Text and English Abst. Only)			XX	
	KR 2000-0015414	3/15/2000	KOREA (Full Korean Text and English Abst. Only)			XX	
	KR 20-0328248	9/18/2003	KOREA (Full Korean Text)				XX
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	KR 2004-0080076	9/18/2004	KOREA (Full Korean Text and English Abst. Only)			XX	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER	/William Doerrler/	DATE CONSIDERED	10/22/2008

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